

RoHS COMPLIANT

### AM7442N-T1-PF-VB Datasheet

## N-Channel 40 V (D-S) MOSFET

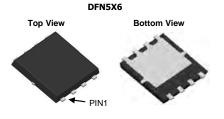
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
40	0.0050 at V <sub>GS</sub> = 10 V	70	67 nC		
40	0.0060 at V <sub>GS</sub> = 4.5 V	65	07 NC		

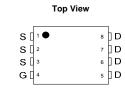
#### **FEATURES**

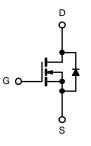
- Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested ٠

#### **APPLICATIONS**

- Notebook PC Core
- VRM/POL •







N-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		70 <sup>a, e</sup>	
Continuous Drain Current (T 175 °C)	T <sub>C</sub> = 70 °C		60 <sup>e</sup>	
Continuous Drain Current ( $T_J = 175 \ ^{\circ}C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	19 <sup>b, c</sup>	A
	T <sub>A</sub> = 70 °C		18.6 <sup>b, c</sup>	
Pulsed Drain Current		I <sub>DM</sub>	120	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	21	
Single Pulse Avalanche Energy	L = 0.1 MH	E <sub>AS</sub>	47.2	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	70 <sup>a, e</sup>	A
Communus Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	2.36 <sup>b, c</sup>	A .
	T <sub>C</sub> = 25 °C		100 <sup>a</sup>	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	PD	55	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' D	6.15 <sup>b, c</sup>	V
	T <sub>A</sub> = 70 °C		3.07 <sup>b, c</sup>	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	ximum Junction-to-Ambient <sup>b, d</sup> $t \le 10 \text{ s}$		47	56	°C/W
Maximum Junction-to-Case Stead		R <sub>thJC</sub>	0.8	1.1	C/W

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 80 A.

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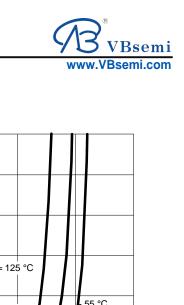
<b>SPECIFICATIONS</b> ( $T_J = 25 \degree C$ , Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static	Symbol	Test conditions		Typ.	IVIAA.	Onic	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	40			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			35		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.2		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
		V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V			1	μA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 V, V_{GS} = 10 V$	70			A	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32 A		0.005		Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 29 A		0.006			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 32 A		110		S	
Dynamic <sup>b</sup>						<b>I</b>	
Input Capacitance	C <sub>iss</sub>			1195		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 12.5 V, $V_{GS}$ = 0 V, f = 1 MHz		975			
Reverse Transfer Capacitance	C <sub>rss</sub>			670			
Total Cata Charge	Qg	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 32 \text{ A}$		67		nC	
Total Gate Charge				57.3			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 4.5 V, $I_D$ = 29 A		31			
Gate-Drain Charge	Q <sub>gd</sub>			25			
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			18	27	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.555 $\Omega$		11	17		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D}\cong 27$ A, $V_{GEN}$ = 10 V, $R_{g}$ = 1 $\Omega$		70	105		
Fall Time	t <sub>f</sub>			10	15		
Turn-On Delay Time	t <sub>d(on)</sub>			55	83		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.625 $\Omega$		180	270		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D} \cong$ 24 A, $\text{V}_\text{GEN}$ = 4.5 V, $\text{R}_\text{g}$ = 1 $\Omega$		55	83		
Fall Time	t <sub>f</sub>			12	18		
Drain-Source Body Diode Characteristic	cs		T	1	r	-	
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			70	A	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			52	78	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		70.2	105	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$r_{\rm r} = 2070, a_{\rm r} a_{\rm r} = 10070 \mu 0, r_{\rm J} = 20.0$		27		ne	
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		25		ns	

Notes:

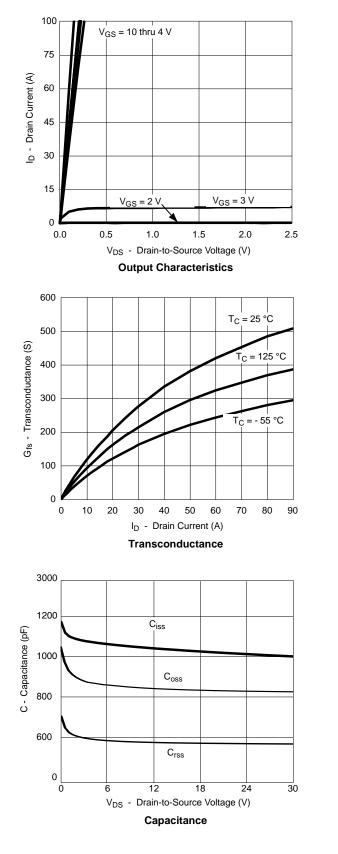
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

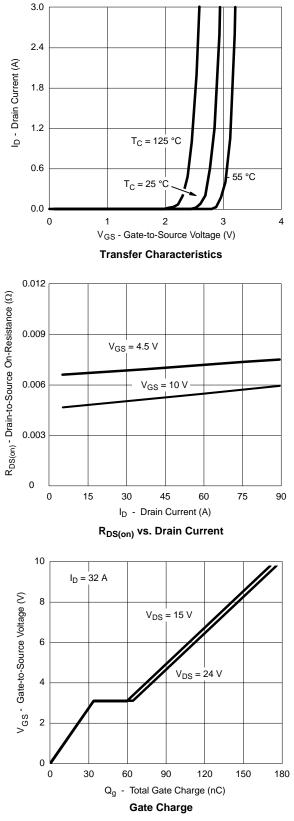
b. Guaranteed by design, not subject to production testing.

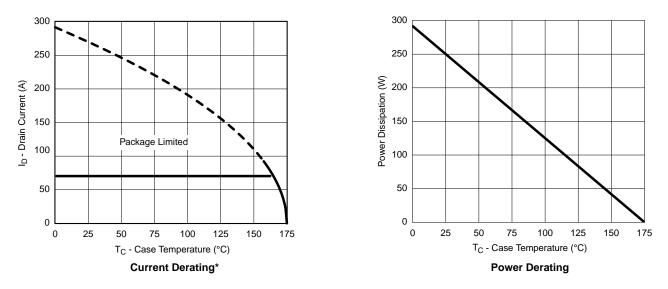
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

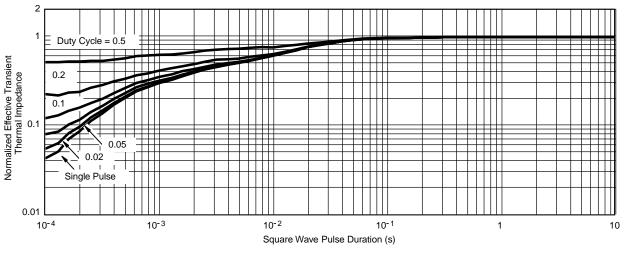






#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

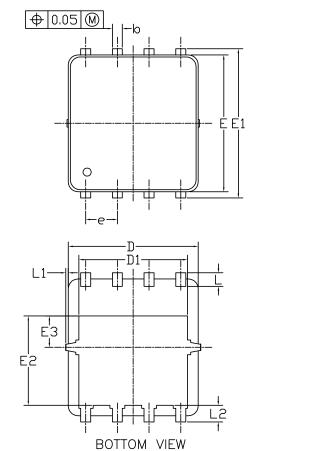
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



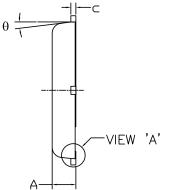
Normalized Thermal Transient Impedance, Junction-to-Case

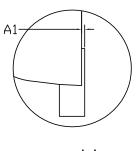
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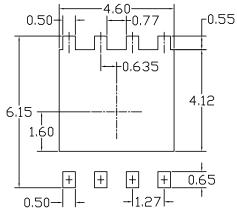
DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN





<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



ava mou a	SYMBOLS DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0.95	1.00	0.033	0.037	0.039	
Al	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0.20	0.25	0.006	0.008	0.010	
D	5.10	5.20	5.30	0.201	0.205	0.209	
D1	4.25	4.35	4.45	0.167	0.171	0.175	
E	5.45	5.55	5.65	0.215	0.219	0.222	
E1	5.95	6.05	6.15	0.234	0.238	0.242	
E2	3.525	3.625	3.725	0.139	0.143	0.147	
E3	1.175	1.275	1.375	0.046	0.050	0.054	
e	1.27 BSC			0.050 BSC			
L	0.45	0.55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

UNIT: mm

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.

MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH. 2. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

NOTE



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